

CM150DX-24S

HIGH POWER SWITCHING USE
INSULATED TYPE

CM150DX-24S



Dual (Half-Bridge)

- 6th Generation NX series -

Collector current I_C 150 A

Collector-emitter voltage V_{CES} 1200 V

Maximum junction temperature T_{jmax} ... 175 °C

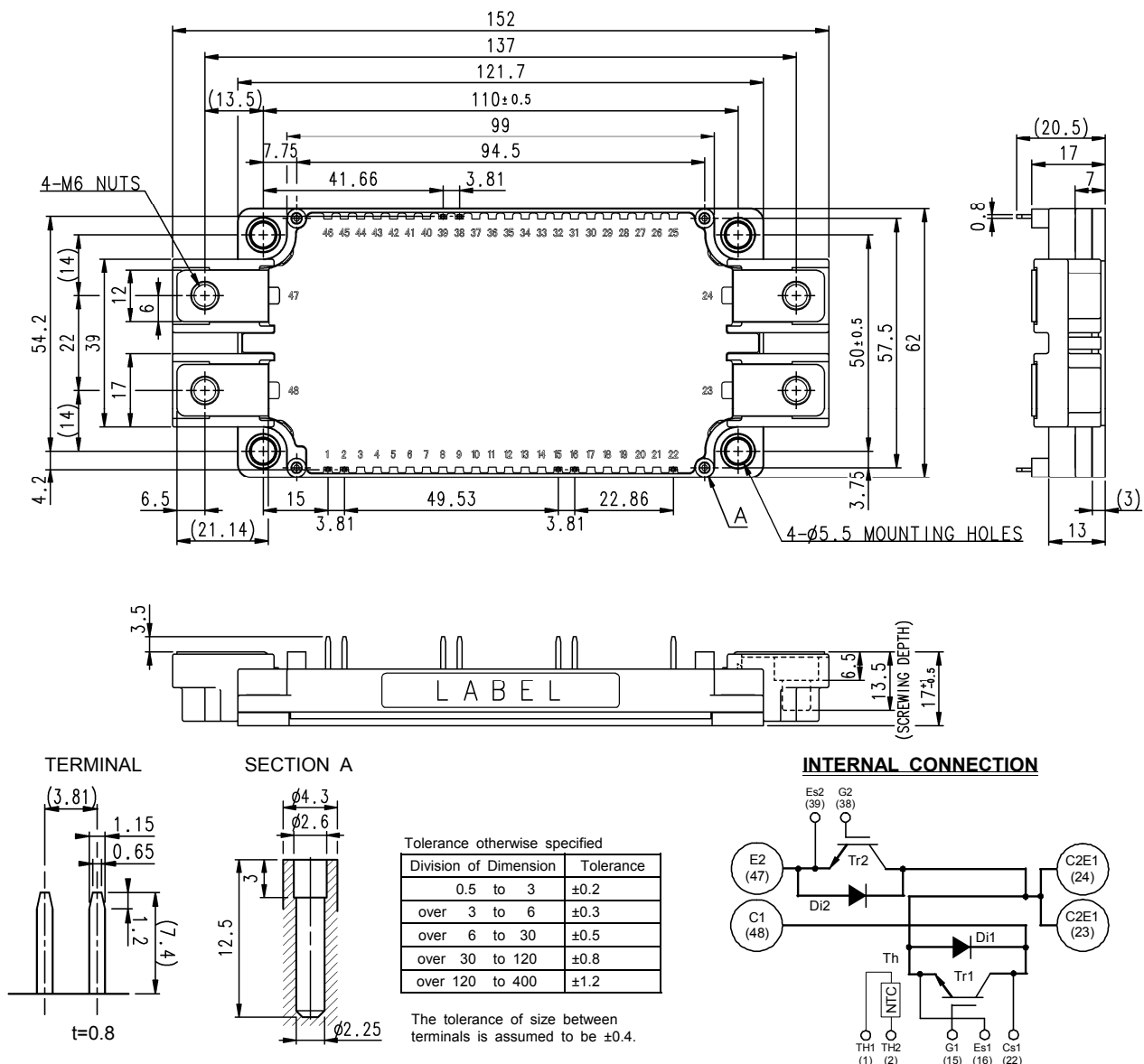
- Flat base Type
- Copper base plate (non-plating)
- Tin plating pin terminals
- RoHS Directive compliant
- UL Recognized under UL1557, File E323585

APPLICATION

AC Motor Control, Motion/Servo Control, Power supply, etc.

OUTLINE DRAWING & INTERNAL CONNECTION

Dimension in mm



ABSOLUTE MAXIMUM RATINGS ($T_j=25\text{ }^{\circ}\text{C}$, unless otherwise specified)**INVERTER PART IGBT/FWDI**

Symbol	Item	Conditions	Rating	Unit
V_{CES}	Collector-emitter voltage	G-E short-circuited	1200	V
V_{GES}	Gate-emitter voltage	C-E short-circuited	± 20	V
I_C	Collector current	DC, $T_C=120\text{ }^{\circ}\text{C}$ (Note.2)	150	A
I_{CRM}		Pulse, Repetitive (Note.3)	300	
P_{tot}	Total power dissipation	$T_C=25\text{ }^{\circ}\text{C}$ (Note.2, 4)	1150	W
I_E (Note.1)	Emitter current	$T_C=25\text{ }^{\circ}\text{C}$ (Note.2, 4)	150	A
I_{ERM} (Note.1)		Pulse, Repetitive (Note.3)	300	

MODULE

Symbol	Item	Conditions	Rating	Unit
T_{jmax}	Maximum junction temperature	-	175	$^{\circ}\text{C}$
T_{Cmax}	Maximum case temperature	(Note.2)	125	
T_{jop}	Operating junction temperature	-	-40 ~ +150	$^{\circ}\text{C}$
T_{stg}	Storage temperature	-	-40 ~ +125	
V_{isol}	Isolation voltage	Terminals to base plate, RMS, f=60 Hz, AC 1 min	2500	V

ELECTRICAL CHARACTERISTICS ($T_j=25\text{ }^{\circ}\text{C}$, unless otherwise specified)**INVERTER PART IGBT/FWDI**

Symbol	Item	Conditions	Limits			Unit	
			Min.	Typ.	Max.		
I _{CES}	Collector-emitter cut-off current	V _{CE} =V _{CES} , G-E short-circuited	-	-	1	mA	
I _{GES}	Gate-emitter leakage current	V _{GE} =V _{GES} , C-E short-circuited	-	-	0.5	μA	
V _{GE(th)}	Gate-emitter threshold voltage	I _C =15 mA, V _{CE} =10 V	5.4	6.0	6.6	V	
V _{CESat} (Terminal)	Collector-emitter saturation voltage	I _C =150 A ^(Note.5) , V _{GE} =15 V	T _J =25 °C	-	1.80	2.25	V
			T _J =125 °C	-	2.00	-	
			T _J =150 °C	-	2.05	-	
V _{CESat} (Chip)	Collector-emitter saturation voltage	I _C =150 A ^(Note.5) , V _{GE} =15 V	T _J =25 °C	-	1.70	2.15	V
			T _J =125 °C	-	1.90	-	
			T _J =150 °C	-	1.95	-	
C _{ies}	Input capacitance	V _{CE} =10 V, G-E short-circuited	-	-	15	nF	
C _{oes}	Output capacitance		-	-	3.0		
C _{res}	Reverse transfer capacitance		-	-	0.25		
Q _G	Gate charge	V _{CC} =600 V, I _C =150 A, V _{GE} =15 V	-	350	-	nC	
t _{d(on)}	Turn-on delay time	V _{CC} =600 V, I _C =150 A, V _{GE} =±15 V, R _G =0 Ω, Inductive load	-	-	800	ns	
t _r	Rise time		-	-	200		
t _{d(off)}	Turn-off delay time		-	-	600		
t _f	Fall time		-	-	300		
V _{EC} ^(Note.1) (Terminal)	Emitter-collector voltage	I _E =150 A ^(Note.5) , G-E short-circuited	T _J =25 °C	-	1.8	2.25	V
			T _J =125 °C	-	1.8	-	
			T _J =150 °C	-	1.8	-	
V _{EC} ^(Note.1) (Chip)	Emitter-collector voltage	I _E =150 A ^(Note.5) , G-E short-circuited	T _J =25 °C	-	1.7	2.15	V
			T _J =125 °C	-	1.7	-	
			T _J =150 °C	-	1.7	-	
t _{rr} ^(Note.1)	Reverse recovery time	V _{CC} =600 V, I _E =150 A, V _{GE} =±15 V, R _G =0 Ω, Inductive load	-	-	300	ns	
Q _{rr} ^(Note.1)	Reverse recovery charge		-	8.0	-	μC	
E _{on}	Turn-on switching energy per pulse	V _{CC} =600 V, I _C =I _E =150 A, V _{GE} =±15 V, R _G =0 Ω, T _J =150 °C, Inductive load	-	24.2	-	mJ	
E _{off}	Turn-off switching energy per pulse		-	16.0	-		
E _{rr} ^(Note.1)	Reverse recovery energy per pulse		-	12.2	-		
R _{CC'+EE'}	Internal lead resistance	Main terminals-chip, per switch, T _C =25 °C ^(Note.2)	-	-	1.8	mΩ	
r _q	Internal gate resistance	Per switch	-	13	-	Ω	

ELECTRICAL CHARACTERISTICS (cont.; $T_J=25\text{ }^{\circ}\text{C}$, unless otherwise specified)
NTC THERMISTOR PART

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
R_{25}	Zero-power resistance	$T_C=25\text{ }^{\circ}\text{C}$ (Note.2)	4.85	5.00	5.15	k Ω
$\Delta R/R$	Deviation of resistance	$T_C=100\text{ }^{\circ}\text{C}$, $R_{100}=493\text{ }\Omega$	-7.3	-	+7.8	%
$B_{(25/50)}$	B-constant	Approximate by equation (Note.6)	-	3375	-	K
P_{25}	Power dissipation	$T_C=25\text{ }^{\circ}\text{C}$ (Note.2)	-	-	10	mW

THERMAL RESISTANCE CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
$R_{th(j-c)Q}$	Thermal resistance (Note.2)	Junction to case, per IGBT	-	-	0.13	K/W
$R_{th(j-c)D}$		Junction to case, per FWDi	-	-	0.23	K/W
$R_{th(c-s)}$	Contact thermal resistance (Note.2)	Case to heat sink, per 1 module, Thermal grease applied (Note.7)	-	15	-	K/kW

MECHANICAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
M_t	Mounting torque	Main terminals M 6 screw	3.5	4.0	4.5	N·m
M_s		Mounting to heat sink M 5 screw	2.5	3.0	3.5	
d_s	Creepage distance	Terminal to terminal	11.55	-	-	mm
		Terminal to base plate	12.32	-	-	
d_a	Clearance	Terminal to terminal	10.00	-	-	mm
		Terminal to base plate	10.85	-	-	
m	Weight	-	-	350	-	g
e_c	Flatness of base plate	On the centerline X, Y (Note.8)	± 0	-	+100	μm

Note.1: Represent ratings and characteristics of the anti-parallel, emitter-collector free wheeling diode (FWDi).

Note.2: Case temperature (T_C) and heat sink temperature (T_s) are defined on the each surface (mounting side) of base plate and heat sink just under the chips. Refer to the figure of chip location.

The heat sink thermal resistance should measure just under the chips.

Note.3: Pulse width and repetition rate should be such that the device junction temperature (T_J) dose not exceed T_{jmax} rating.

Note.4: Junction temperature (T_J) should not increase beyond T_{jmax} rating.

Note.5: Pulse width and repetition rate should be such as to cause negligible temperature rise.

Refer to the figure of test circuit for V_{CESat} , V_{EC} .

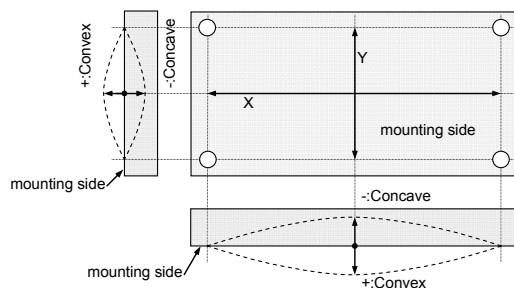
Note.6: $B_{(25/50)} = \ln\left(\frac{R_{25}}{R_{50}}\right) / \left(\frac{1}{T_{25}} - \frac{1}{T_{50}}\right)$

R_{25} : resistance at absolute temperature T_{25} [K]; $T_{25}=25\text{ }^{\circ}\text{C}+273.15=298.15\text{ [K]}$

R_{50} : resistance at absolute temperature T_{50} [K]; $T_{50}=50\text{ }^{\circ}\text{C}+273.15=323.15\text{ [K]}$

Note.7: Typical value is measured by using thermally conductive grease of $\lambda=0.9\text{ W/(m}\cdot\text{K)}$.

Note.8: The base plate (mounting side) flatness measurement points (X, Y) are as follows of the following figure.



Note.9: Japan Electronics and Information Technology Industries Association (JEITA) standards,

"EIAJ ED-4701/300: Environmental and endurance test methods for semiconductor devices (Stress test I)"

Note.10: Use the following screws when mounting the printed circuit board (PCB) on the stand offs.

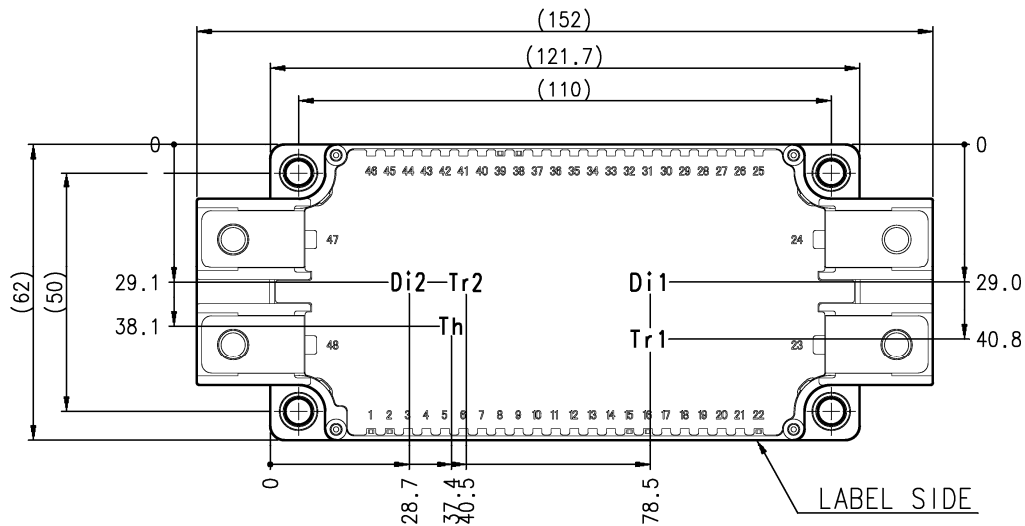
"M2.6×10 or M2.6×12 self tapping screw"

The length of the screw depends on the thickness of the PCB.

RECOMMENDED OPERATING CONDITIONS ($T_a=25\text{ }^{\circ}\text{C}$)

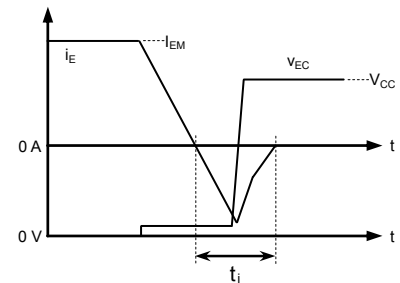
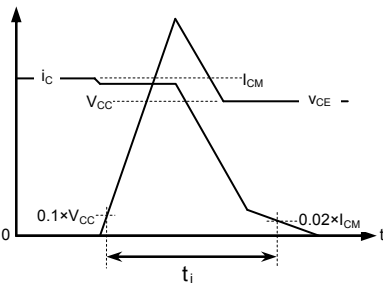
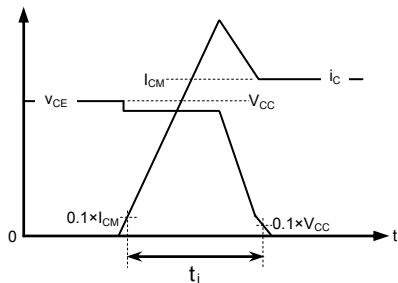
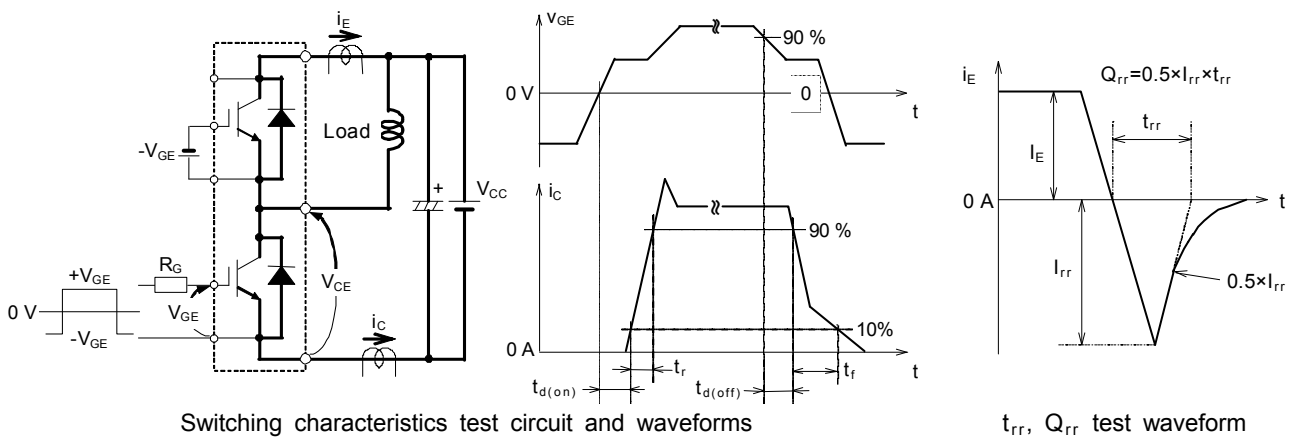
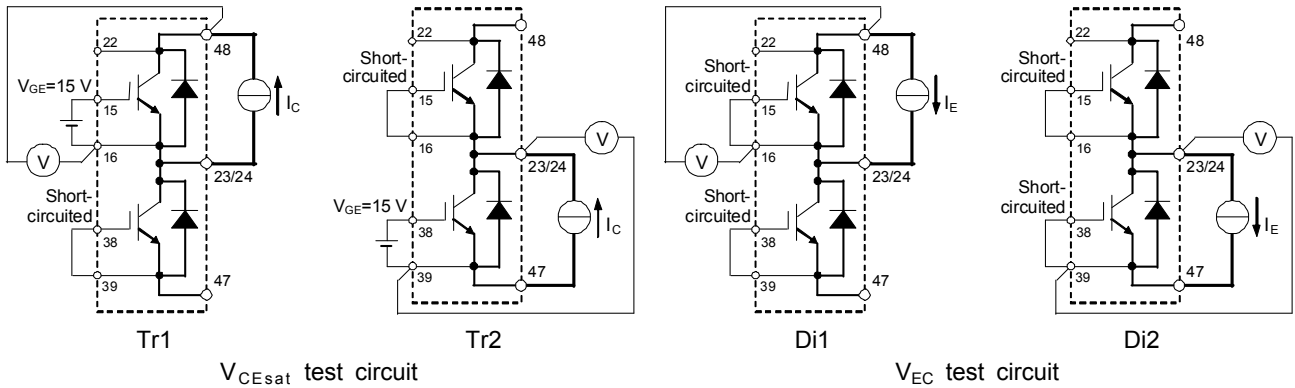
Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
V_{CC}	(DC) Supply voltage	Applied across C1-E2	-	600	850	V
V_{GEon}	Gate (-emitter drive) voltage	Applied across G1-Es1/G2-Es2	13.5	15.0	16.5	V
R_G	External gate resistance	Per switch	0	-	30	Ω

CHIP LOCATION (top view)

Dimension in mm, tolerance: ± 1 mm


Tr1/Tr2: IGBT, Di1/Di2: FWDi, Th: NTC thermistor. Each mark points the center position of each chip.

TEST CIRCUIT AND WAVEFORMS

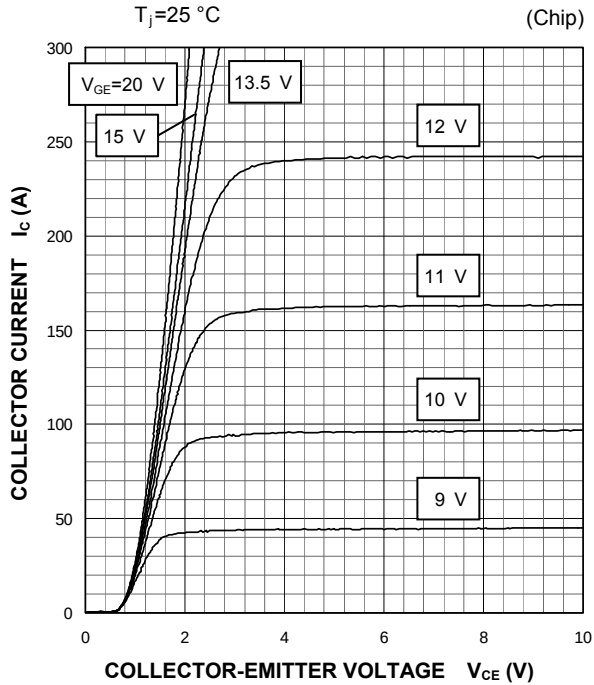


Turn-on / Turn-off switching energy and Reverse recovery energy test waveforms (Integral time instruction drawing)

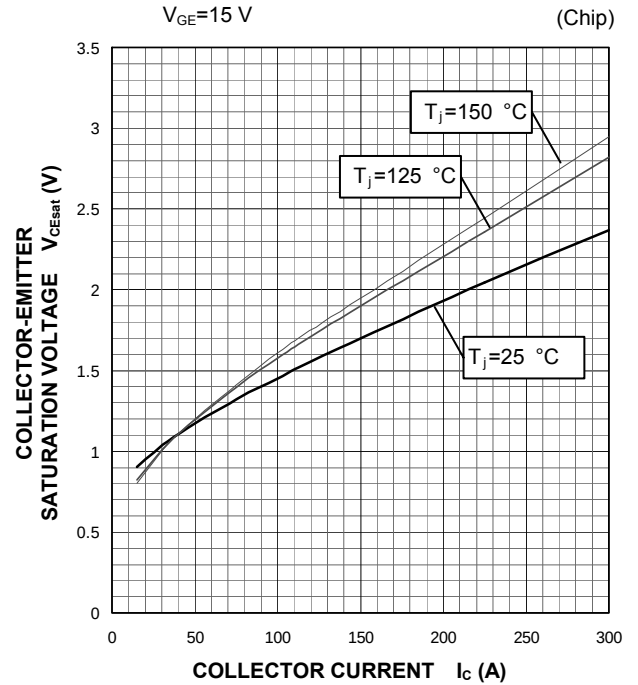
PERFORMANCE CURVES

INVERTER PART

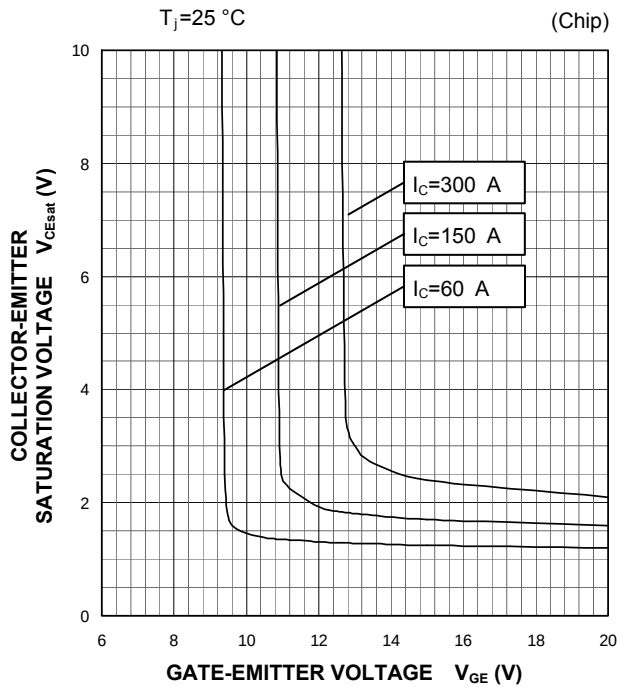
OUTPUT CHARACTERISTICS
(TYPICAL)



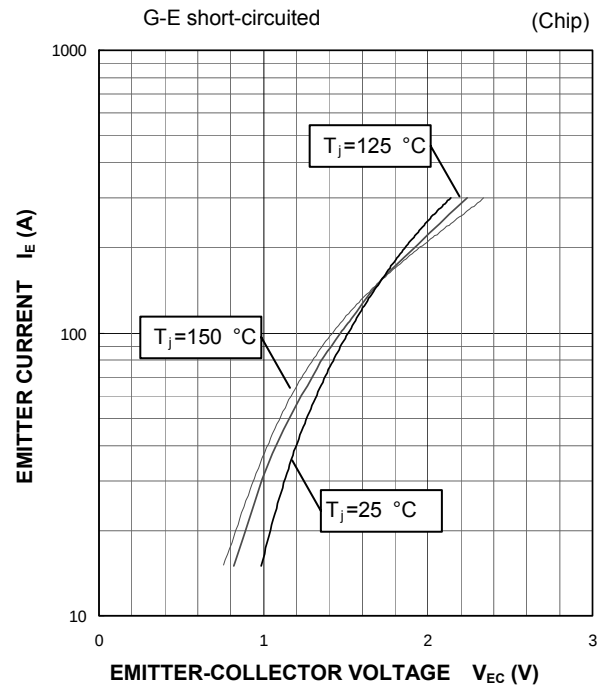
COLLECTOR-EMITTER SATURATION
VOLTAGE CHARACTERISTICS
(TYPICAL)



COLLECTOR-EMITTER SATURATION
VOLTAGE CHARACTERISTICS
(TYPICAL)

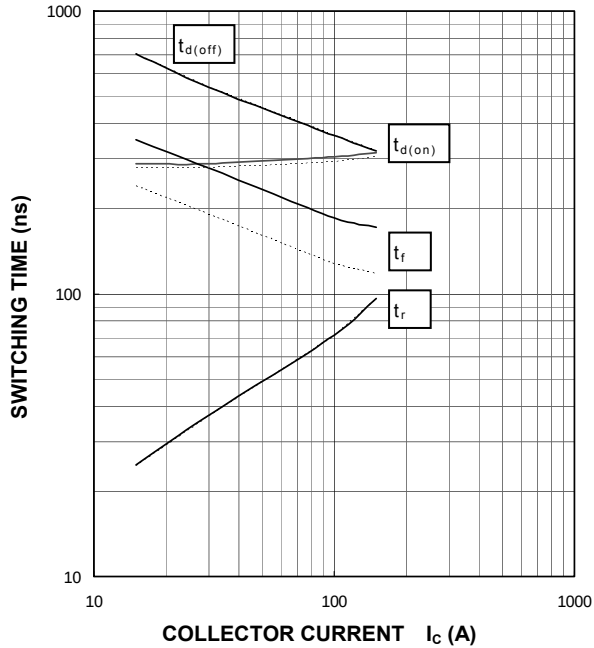


FREE WHEELING DIODE
FORWARD CHARACTERISTICS
(TYPICAL)

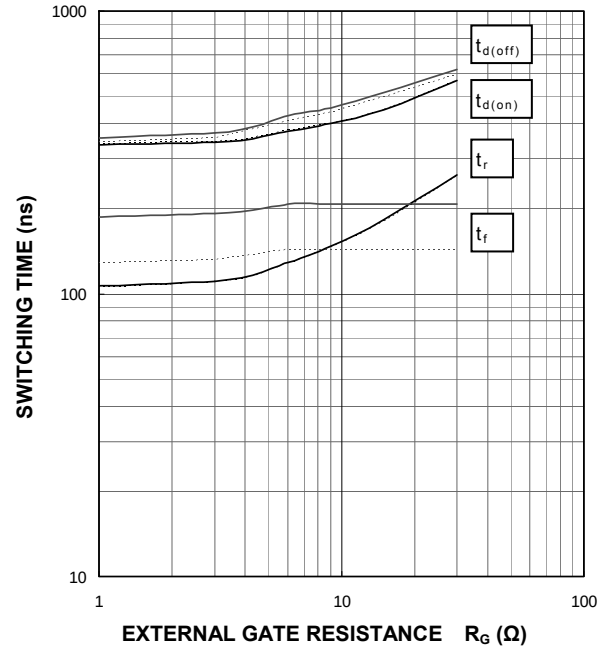


**HALF-BRIDGE
SWITCHING CHARACTERISTICS
(TYPICAL)**

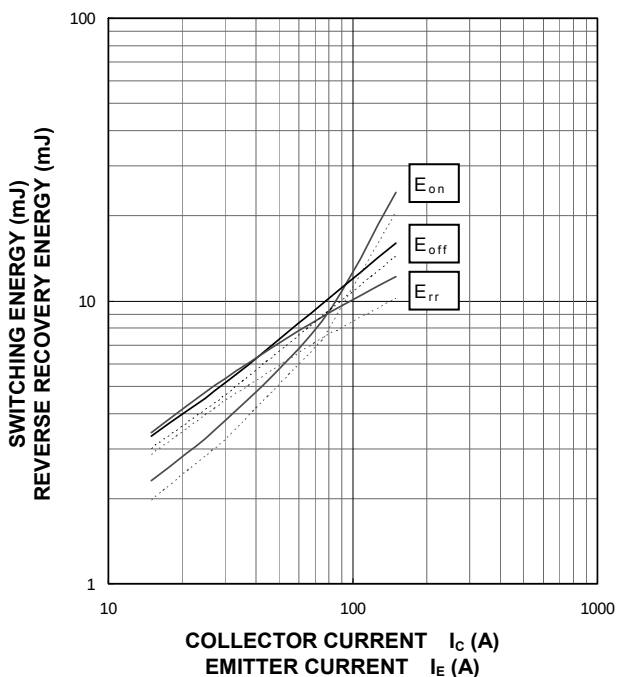
$V_{CC}=600\text{ V}$, $V_{GE}=\pm 15\text{ V}$, $R_G=0\ \Omega$, INDUCTIVE LOAD
 —: $T_J=150\text{ }^\circ\text{C}$, - - - -: $T_J=125\text{ }^\circ\text{C}$

**HALF-BRIDGE
SWITCHING CHARACTERISTICS
(TYPICAL)**

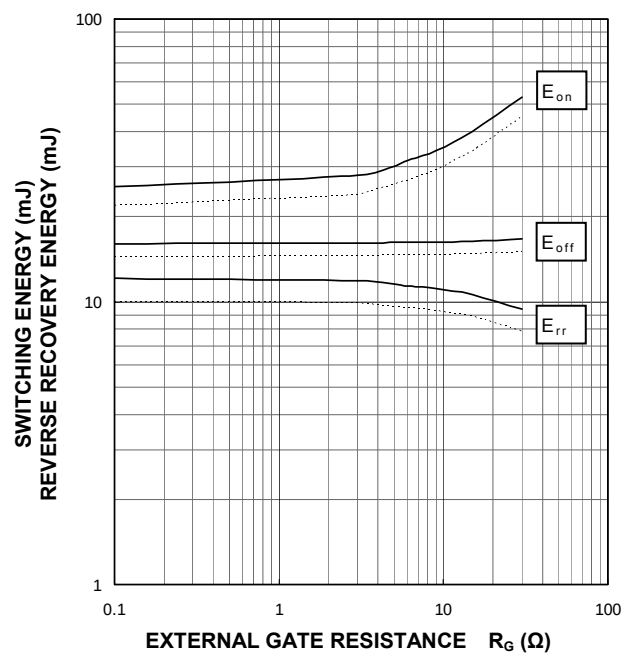
$V_{CC}=600\text{ V}$, $I_C=150\text{ A}$, $V_{GE}=\pm 15\text{ V}$, INDUCTIVE LOAD
 —: $T_J=150\text{ }^\circ\text{C}$, - - - -: $T_J=125\text{ }^\circ\text{C}$

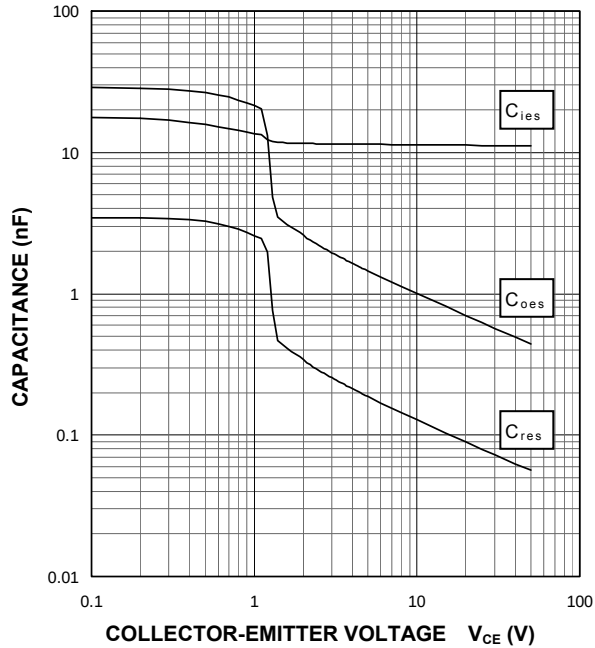
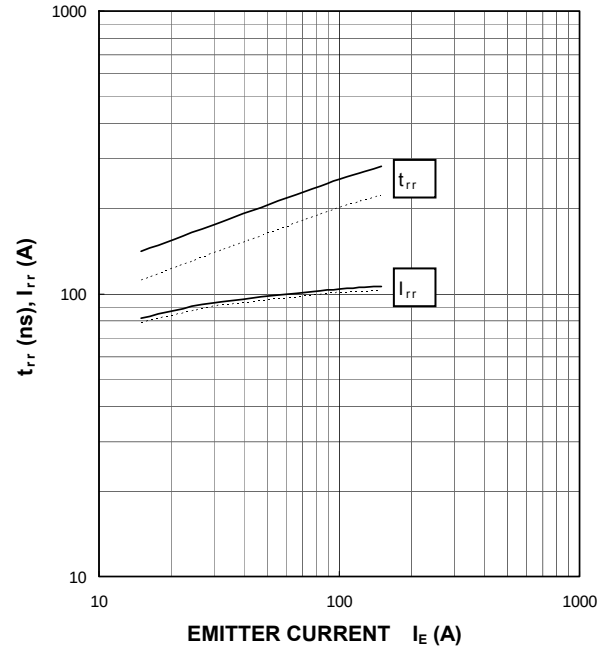
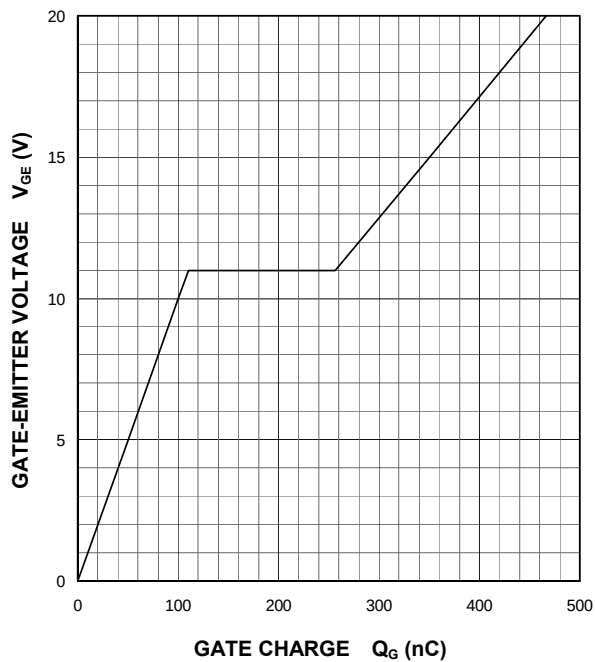
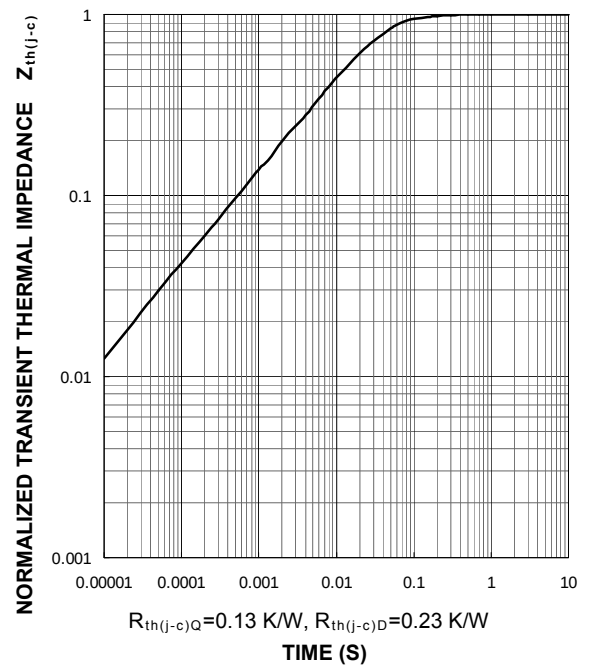
**HALF-BRIDGE
SWITCHING CHARACTERISTICS
(TYPICAL)**

$V_{CC}=600\text{ V}$, $V_{GE}=\pm 15\text{ V}$, $R_G=0\ \Omega$,
INDUCTIVE LOAD, PER PULSE
 —: $T_J=150\text{ }^\circ\text{C}$, - - - -: $T_J=125\text{ }^\circ\text{C}$

**HALF-BRIDGE
SWITCHING CHARACTERISTICS
(TYPICAL)**

$V_{CC}=600\text{ V}$, $I_C/I_E=150\text{ A}$, $V_{GE}=\pm 15\text{ V}$,
INDUCTIVE LOAD, PER PULSE
 —: $T_J=150\text{ }^\circ\text{C}$, - - - -: $T_J=125\text{ }^\circ\text{C}$



**CAPACITANCE CHARACTERISTICS
(TYPICAL)**G-E short-circuited, $T_j=25^\circ\text{C}$ **FREE WHEELING DIODE
REVERSE RECOVERY CHARACTERISTICS
(TYPICAL)** $V_{CC}=600\text{ V}$, $V_{GE}=\pm 15\text{ V}$, $R_G=0\ \Omega$, INDUCTIVE LOAD
—: $T_j=150^\circ\text{C}$, - - - : $T_j=125^\circ\text{C}$ **GATE CHARGE CHARACTERISTICS
(TYPICAL)** $V_{CC}=600\text{ V}$, $I_C=150\text{ A}$, $T_j=25^\circ\text{C}$ **TRANSIENT THERMAL IMPEDANCE
CHARACTERISTICS
(MAXIMUM)**Single pulse, $T_C=25^\circ\text{C}$ 

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